RSC Advances

Cite this: RSC Adv., 2015, 5, 93765

Effects of Ga doping and hollow structure on the band-structures and photovoltaic properties of SnO2 photoanode dye-sensitized solar cells†

Yandong Duan,‡^{ab} Jiaxin Zheng,‡^a Nianqing Fu,^{bc} Jiangtao Hu,^a Tongchao Liu,^a Yanyan Fang,^b Qian Zhang,^d Xiaowen Zhou,^b Yuan Lin^{*ab} and Feng Pan^{*a}

The photon-to-electricity conversion properties of the prepared photoanode based on SnO₂ nanocrystals, which are assembled as the rough hollow microspheres (RHMs), are improved by aliovalent Ga $3+$ doping. The conduction band (CB) of the doped $SnO₂$ shifts negatively with increasing the Ga content from 1 to 5 mol% gradually. Moreover, the prepared Ga-doped $SnO₂$ photoanode shows an advantage in repressing the charge recombination. As a result, both the negative shift of the CB and repressed charge recombination enhance the open-circuit photovoltage (V_{oc}) and the short-circuit photocurrent (J_{sc}) of the DSSCs, and the power conversion efficiency (η) is increased by 80% at 3 mol% Ga-doping SnO₂ to compare with the undoped $SnO₂$ for DSSCs (AM 1.5, 100 mW cm⁻²). After treating the samples with TiCl₄, an overall photoconversion efficiency (approximately 7.11%) for SnO₂ based DSSCs is achieved. **PAPER**
 Effects of Ga doping and hollow structure on the same of the mass of the same of

Received 21st September 2015 Accepted 27th October 2015

DOI: 10.1039/c5ra19491a

www.rsc.org/advances

Introduction

As the next generation solar cells, DSSCs have received much attention because of their low cost, chemical stability, and convenient fabrication.1,2 Many efforts to improve the energyconversion efficiency (η) of DSSCs have been focused on the improvement of the photoanode, dye, electrolyte, cathode, their interfaces, and the fabrication technologies. So far the highest energy conversion efficiencies (>12%) have been achieved with nanocrystalline anatase $TiO₂$ photoanode.³ However, further improvement in the photovoltaic performance is limited

because of its low electron mobility (<1 cm² V⁻¹ s⁻¹) and transport properties.⁴ As a result, to seek new alternative photoanode materials, other metal oxide semiconductors such as ZnO,⁵ SnO₂,^{6,7} SrTiO₃,⁸ and Zn₂SnO₄ (ref. 9) have been investigated recently as promising photoelectrodes for DSSCs.

YAL SOCIETY
CHEMISTRY

Especially, nanostructured $SnO₂$ has been considered as an ideal and important substitutive material because of its higher electron mobility (125-250 cm² V⁻¹ S⁻¹) and photostability to compare with those of $TiO₂$. However, the cell performance of $SnO₂$ -based DSSCs is still far from satisfactory due to the following drawbacks,¹⁰ such as that (1) the more positive (ca. 300 mV) conduction band edge of $SnO₂$ compared with $TiO₂$ leads to faster interfacial electron recombination, (2) the lower isoelectric point (pI: 4-5) of $SnO₂$ compared with anatase $TiO₂$ (pI: $6-7$) results in less adsorption of the dye.¹¹ Developing effective methods to overcome the above drawbacks would improve the energy conversion efficiency of $SnO₂$ based DSSCs greatly, such as downsizing the particle size to the nanoscale to increase the specific surface area for more dye loading and surface treatment to repress the interfacial electron recombination.^{12–15} Table S1[†] shows a comparison for different methods (morphology controlling, metal doping, surface coating, etc.) to improve the photovoltaic performance of the $SnO₂$ based DSSCs.11,12,16–²⁴

Doping metal atoms into photoanodes is a widely adopted method to tailor their properties, such as the electrical conductance, conductance band position, charge recombination rates, and trap/defect level distribution.²⁵⁻²⁷ For example, it is reported that Nb-doped $TiO₂$ and the Nb doping can lead to a significant increase of powder conductivity and a positive shift in the V_{fb}^{28} Mg-doping in SnO₂ can reduce the charge

[&]quot;School of Advanced Materials, Peking University Shenzhen Graduate School, Shenzhen 518055, China. E-mail: panfeng@pkusz.edu.cn; Tel: +86-755-26033200

^bBeijing National Laboratory for Molecular Sciences, Key Laboratory of Photochemistry, Institute of Chemistry, Chinese Academy of Sciences, Beijing 100190, China. E-mail: linyuan@iccas.ac.cn; Fax: +86-10-82617315; Tel: +86-10- 82615031

c Department of Applied Physics, The Hong Kong Polytechnic University, Hung Hom, Kowloon, Hong Kong, China

^aState Key Laboratory for Advanced Metals and Materials, School of Materials Science and Engineering, University of Science and Technology Beijing, Beijing 100083, China † Electronic supplementary information (ESI) available: Mott–Schottky plots of the $SnO₂$ and the Ga-doped $SnO₂$ films. Diffuse reflectance spectra of the photoelectrodes with nano $SnO₂$, nano hollow $SnO₂$ and nano hollow $Sn_{0.97}Ga_{0.03}O_2$. Specific resistivity as a function of doping level for $Sn_{1-x}Ga_xO_2$ films. Normalized device performance under constant illumination for 100 h measured in air. Elemental mapping of the $Sn_{0.97}Ga_{0.03}O_2$. Calculated total and orbital resolved densities of states for the pure $SnO₂$ and 6.25% Ga doped $SnO₂$. The reported high values of η obtained in the DSSCs based on different SnO₂ photoanode structures. Calculated structural parameters a and c for pure SnO₂ and 6.25% Ga doped SnO2. See DOI: 10.1039/c5ra19491a

[‡] These authors contributed equally to this work.

recombination and prolong the electron lifetime in DSSCs device.¹³ Teng et al. reported that the density of empty trap states for electron localization is smaller for the Zn-doped TiO₂ films relative to that of the bare-TiO₂ film due to increased band bending resulting from the elevated electron Fermi level.²⁹ Gadoped $SnO₂$ has been applied in photocatalysis, resulting in an increase in the photocurrent and photovoltage compared with non-doped $SnO₂$. However, there is no detailed study about the mechanism of electron lifetime and electron transport in the Ga-doped $SnO₂$ samples, and the overall photoconversion efficiency is unsatisfactory (4.05%) .³⁰ Heterovalent substitution is an effective approach to directly affect the Fermi level and further increase the carrier concentration. In a previous work of ours,³¹ we reported that both tuning the conduction band and suppressing the charge recombination are synchronously improved in the Al^{3+} -doped SnO₂ photoanode, and a high energy-conversion efficient of 6.91% for Al-doped SnO₂ DSSCs can be easily obtained. Analogously, Ga^{3+} doping is also anticipated to improve the performance of $SnO₂$ based DSSCs. RSC Advances

recombination and protony the electron University Topy columerations in the

model on 27 October 2015. The property of the control of the columerations of the model

state for electron by University Topy (Th

Moreover, to further improve the performance of $SnO₂$ based DSSCs, the electrode structure should be modified. Nanostructured hollow spheres have been demonstrated to be efficient materials because of their low density, high specific surface area, light scattering ability and densely packed microstructure for fast electron transport. In this work, the Ga-doped $SnO₂$ nanocrystals to self-assemble as rough hollow microspheres (RHMs) photoanodes for DSSCs were prepared by the hydrothermal method. The doped $SnO₂$ samples with Ga show both improvements of significant reduction of the electron recombination and optimization of the band structure. With a $TiCl₄$ post treatment, the high overall photoconversion efficiency of approximately 7.11% for DSSCs based on Ga-doped $SnO₂$ is achieved, which is over 2 times higher than that of pure $SnO₂$ samples. This value is not only larger than that for our previous Al-doped SnO₂ DSSCs (6.91%) but also one of the highest so far to compare with the other reported high values for $SnO₂$ based DSSCs (Table S1 \dagger). Finally, the mechanism behind the improvement by Ga-doping was discussed by the experimental measurements and the density functional theory (DFT) calculations.

Experimental section

Materials

 $SnCl₂·2H₂O$ (AR, Sinopharm Chemical Reagent Co., Ltd.), $Ga(NO₃)·9H₂O$ (99.9%, Alfa), LiI (AR, Acros), I₂ (AR, Acros), and 4-tert-butylpyridine (TBP, AR, Aldrich), 3-methoxypropionitrile (MPN, 99%, GC, Alfa) were commercially available. All the chemicals were used without further purification. 3-Hexyl-1methylimidazolium iodide was prepared according to the literature.³² The electrode substrate is fluorine-doped tin oxide conducting glass (FTO, Nippon Sheet Glass; thickness, 2.2 mm; sheet resistance, 14 Ω per square).

Synthesis of $SnO₂$ and Ga-doped $SnO₂$

The pure SnO₂ rough hollow microspheres were synthesized according to the literature.²¹ In a typical synthesis process, 3 mL of concentrated hydrochloric acid (37.5 wt%) was added to ethanol/distilled water (165 ml, 30/3, v/v). The mixture was stirred under ambient conditions for 3 min before 0.75 g of $SnCl₂·2H₂O$ was added. Then the turbid precursor was stirred for 60 min. The resulting solution was transferred to a Teflonlined stainless steel autoclave of 200 mL volume and kept in an air-flow electric oven at 200 $^{\circ}$ C for 24 h. Afterward, the autoclave was taken out to cool down naturally. The white precipitate was then harvested by centrifugation and washed thoroughly with ultrapure water before drying at 80 °C overnight. For preparing of the Ga-doped samples, $Ga(NO₃) \cdot 9H₂O$ and $SnCl₄·5H₂O$ was added to ethanol/distilled water (molar ratio of Ga and Sn were 1 : 99, 3 : 97 and 5 : 95) to start the hydrothermal process. The obtained samples was denoted as $SnO₂, Sn_{0.99}Ga_{0.01}O₂, Sn_{0.97}Ga_{0.03}O₂ and Sn_{0.95}Ga_{0.05}O₂.$

Cell fabrication and photovoltaic measurements

SnO₂ and Ga-doped SnO₂ films (ca. 8–9 μ m) were fabricated on the FTO substrates using a doctor-blade method and the electrodes were sintered at 450 °C for 30 min. TiCl₄ surface treating is conducted by dipping the photoanodes in 40 mM $TiCl₄$ aqueous solution at 70 \degree C for 30 min and then sintering under 500 °C. After the heating, when the temperature cooled to 80 °C, the electrodes were immersed in a dye bath containing 0.5 mM $cis-Ru(H_2dcby)_2(NCS)_2$ $(H_2dcby = 4,4'-dicarboxy-2,2'-bipyr-2')$ idyl) (N3) in ethanol for 24 h. The film thickness was measured by SEM. Then, the N3-loaded electrode was assembled with the prepared Pt counter electrode to form a sandwich-type DSCs. A drop of electrolyte solution (composition: 0.5 M LiI, 0.05 M I2, 0.6 M TBP, and 0.6 M HMII in MPN) was added between the two electrodes of the cell. The photovoltaic performance was measured using a Keithly 2611 Source Meter (Keithley Instruments, Inc.). The light source was a AM 1.5 solar simulator (91160A, Newport Co.). The incident light intensity (100 mW $\rm cm^{-2})$ was adjusted with a standard Silicon reference solar cell and the cell active area was 0.20 cm^2 .

Characterization

The crystalline phase was confirmed using high-power X-ray diffraction (XRD, Rigaku D/MAX 2500 V diffractor) with Cu Ka radiation. High-resolution transmission electron microscopy (HR-TEM, Tecnai G2 20 S-TWIN) was used to examine the morphology and mesopore structures. X-ray photoelectron spectroscopy (XPS) measurements were performed using an Al Ka radiation (1486.6 eV) (ESCALab220i-XL, VG Scientific) at \sim 3 \times 10⁻⁹ mbar background pressure. The binding energies are calibrated by C1s photoelectron peak (284.8 eV). A threeelectrode system was employed for measuring Mott–Schottky plots with $SnO₂$ or Ga-doped $SnO₂$ films (without dyes, ca. 3 µm) as a photoanode, an saturated calomel electrode (SCE) and a platinum wire as reference electrode and counter electrode, respectively. The active area was 0.25 cm^2 . SnO₂ or Ga-doped $SnO₂$ films (ca. 3 µm) adsorbed by dyes were used for the EIS, IMPS, and IMVS test. Electrochemical impedance spectroscopy (EIS) measurements were carried out with Solartron 1255B frequency analyzer and Solartron SI 1287 electrochemical

interface system (light intensity: 100 mW $\rm cm^{-2}$). IMPS and IMVS were obtained using a green light emitting diode (max $= 520$ nm) driven by a Solartron 1255B frequency-response analyzer. The LED provided both the dc and ac components of the illumination. The specific resistivity were conducted using a fourprobe technique (KDY-1, Kunde Technology).

Computational details

In order to model the SnO₂ doped by Ga, a $2 \times 2 \times 2$ supercell (48 atoms) based on the unit cell was constructed, allowing us to investigate different substitution degrees of $Sn_{1-x}Ga_xO_2$. All calculations are performed using the generalized Kohn–Sham theory with the screened hybrid functional of Heyd, Scuseria, and Ernzerhof (HSE)³³⁻³⁶ as implemented in the Vienna ab initio simulation package.^{37,38} Compared with conventional functionals such as PBE and PBE0, the HSE hybrid functional can produce more close results to experimental values, such as lattice constants, band gaps, and formation enthalpies.³⁹ In this approach, a fraction of Hartree–Fock (HF) exchange potential is mixed with the exchange potential of the Perdew–Burke–Ernzerhof (PBE)⁴⁰ form of generalized gradient approximation (GGA). Here the HF mixing parameter was set to 0.32 to yield good agreement with the experimental bandgap of SnO₂.⁴¹ To obtain reliable optimized structures, the maximum residual force is less than 0.01 eV \AA^{-1} and energies are converged to within 5 \times 10⁻⁶ eV per atom. The *k*-point mesh is set to 2 \times 2 \times 2 to calculate electronic properties. An energy cut-off of 450 eV was used in all cases. **Puper**
 EXAMPEDIESE AND THEST UNIVERSE CONSULTER CONSULTER

We first calculated the formation energies for the doping site of substituting a Sn atom and a interstitial site, respectively. Here, we calculate the formation energy of a Sn atom substituted by a Ga atom using the following formula:

$$
E^{\text{f}}(\text{Ga}^{\text{Sn}}) = E_{\text{tot}}(\text{Ga}^{\text{Sn}}) + \mu_{\text{Sn}} - E_{\text{tot}}(\text{bulk}) - \mu_{\text{Ga}} \tag{1}
$$

The formation energy of a Ga interstitial doping is calculated as:

$$
E^{f}(\text{Ga}^{\text{int}}) = E_{\text{tot}}(\text{Ga}^{\text{int}}) - E_{\text{tot}}(\text{bulk}) - \mu_{\text{Ga}} \tag{2}
$$

where $E_{\text{tot}}(\text{Ga}^{\text{Sn}})$, $E_{\text{tot}}(\text{bulk})$, and $E_{\text{tot}}(\text{Ga}^{\text{int}})$ are, respectively, the total energies of a supercell in which a Sn atom has been substituted by a Ga atom, a supercell of the perfect bulk $SnO₂$ material, and a supercell of a Ga interstitial doping; μ_{Sn} and μ_{Ga} are, respectively, the atomic chemical potentials of species Sn and Ga (referenced to the standard state). The chemical potentials depend on experimental conditions and sources of impurities and can be estimated from experimental formation enthalpies. We can compare the $\it{E}^{\rm f}(\rm{Ga}^{\rm{Sn}})$ with $\it{E}^{\rm f}(\rm{Ga}^{\rm{int}})$ by using eqn (1) minus eqn (2):

$$
E^{\text{f}}(\text{Ga}^{\text{Sn}}) - E^{\text{f}}(\text{Ga}^{\text{int}}) = [E_{\text{tot}}(\text{Ga}^{\text{Sn}}) - E_{\text{tot}}(\text{Ga}^{\text{int}})] + \mu_{\text{Sn}} \tag{3}
$$

Based on our calculation results, we can get $E^f(\text{Ga}^{\text{Sn}})$ – $E^{\rm f}({\rm Ga}^{\rm int})$ to be (3.79 eV + $\mu_{\rm Sn}$), which depends on the chemical potential of Sn. To simulate experimental synthesis conditions, we assume that Sn potential μ_{Sn} depends on oxygen pressure in

the synthesis system.⁴² In our calculations for the oxygen-rich limit, $\mu_{\text{Sn}} = \mu_{\text{Sn(metal)}} + \Delta H_{\text{Sno}_2}$, and for the oxygen-poor limit, $\mu_{\text{Sn}} = \mu_{\text{Sn(metal)}}$. Here $\mu_{\text{Sn(metal)}}$ is calculated to be -4.009 eV, thus we can get $E^{\text{f}}(\text{Ga}^{\text{Sn}}) - E^{\text{f}}(\text{Ga}^{\text{int}})$ to be -0.21 eV at the oxygenpoor limit. For the oxygen-rich limit, because $\Delta H_{\rm Sno}$ is negative, $E^{\text{f}}(\text{Ga}^{\text{sn}}) - E^{\text{f}}(\text{Ga}^{\text{int}})$ will still be negative. As a result, compared with Ga doping at an interstitial, Ga substituting Sn atom will be energy favorable. This is also supported by the XRD results, which shows that the lattice constants decrease after Ga doping. The DFT calculations show that the lattice constants of $SnO₂$ would increase after Ga interstitial doping (Table S2†), which contradicts the XRD results. By contrast, the lattice constants of $SnO₂$ would decrease after Ga substituting Sn atoms (Table S2†), consistent with the XRD results.

Additionally, because the absolute position of energy levels in a bulk calculation is ill-defined by DFT calculations, here we pick the deep core levels of a Ga atom (far from the doped Ga atom, see red cycled atom in Fig. $7(a)$) to align the energy levels in different calculations.

Results and discussions

The XRD patterns of Ga-doped $SnO₂$ calcined at 450 °C in air for 30 min are presented in Fig. 1(a). All of the undoped and the Gadoped SnO₂ have a tetragonal rutile crystal structure (PDF No. 77-0448) and no other crystalline forms are detected. As can be seen in the inset of Fig. $1(a)$, the diffraction peaks shift to higher theta values with increasing Ga^{3+} content to reveal a narrowing of the lattice constant in accordance with the Bragg equation: 2d sin $\theta = \lambda$, which can be attributed to the substitution of Sn⁴⁺ by Ga³⁺ because of the smaller effective radius of Ga³⁺(0.62 Å) compared to that of $Sn^{4+}(0.69 \text{ Å})$. In Fig. 1(b), the sizes of the $SnO₂$ nanoparticles, as calculated by the Scherrer equation, decline from 15.85 nm to 13.79 nm as the amount of Ga^{3+} ions increases from 1 to 5 mol%. This is similar to the Al-doping cases, as the average diameter size of $SnO₂$ decreases from ca. 16 nm to ca . 12 nm after the Al-doping.

The morphologies of the samples are studied by SEM as shown in Fig. 2(a) and (b). The as-synthesized $SnO₂$ and $Sn_{0.97}Ga_{0.03}O₂$ samples demonstrate the aggregated uniform hollow structure with a diameter of about 300 nm. These hollow nanospheres are assembled with $SnO₂$ or $Sn_{0.97}Ga_{0.03}O₂$ nanoparticles with shell thickness of about 80-100 nm confirmed by high-resolution TEM, as shown in Fig. 2(c) and (d). These morphologies are different from the hydrothermal synthesized Al-doped $SnO₂$ nanoparticles, which show little aggregation. The HRTEM images show lattice fringes with regular spacings of 0.34 nm, which are associated with the (110) planes of SnO₂ and $Sn_{0.97}Ga_{0.03}O_2$. The well resolved fringes indicate that the $SnO₂$ and $Sn_{0.97}Ga_{0.03}O₂$ nanocrystals possess the high crystallinity.

The binding energies of $SnO₂$ and $Sn_{0.97}Ga_{0.03}O₂$ samples were referenced to the C1s (284.8 eV) line measured by the XPS spectra (Fig. 3). The tin core levels $Sn3d_{5/2}$ and $Sn3d_{3/2}$ are observed at 486.05 and 494.50 eV, respectively, with a peak-topeak separation of 8.45 eV. Compared with the pure $SnO₂$ sample, a slight negative shift in binding energy was found from

Fig. 1 (a) XRD patterns of SnO₂ and Ga-doped SnO₂; (b) plots of doping content vs. particle size, derived using the Scherrer equation.

Fig. 2 SEM images of (a) $SnO₂$, and (b) $Sn_{0.98}Ga_{0.03}O₂$. TEM, HR-TEM and FFT (inset) images of (c) SnO₂, and (d) Sn_{0.97}Ga_{0.03}O₂.

the $Sn_{0.97}Ga_{0.03}O_2$ samples. The charge transfer occurring between two cationic species has been well studied with XPS for many mixed oxides, where the metallic ions are mixed at an atomic level, forming a heterogeneous linkage of M(A)–O–M(B) (where M(X) represents different metallic species). The electron cloud will be transferred from one type of cation to the other through their oxygen bridge in the linkage structure due to the different cation charge and electronegativity.^{43,44} In this case, the binding energy shift arises from electron transfer from Ga to Sn due to the differences of their electron negativity (electron negativity: Sn = 1.96, Ga = 1.81). The positions of Ga2 $p_{1/2}$ and Ga2 $p_{3/2}$ peaks are at 1118.1 and 1145.1 eV, respectively. These positions are in good agreement with the values previously reported by Schon, suggesting that Ga exists in the form of Ga³⁺.⁴⁵

Fig. 4(a) shows the current density (J) –voltage (V) curves of DSSCs with the undoped $SnO₂$ and Ga-doped $SnO₂$ as the work electrode materials under simulated AM 1.5G illumination (100 $mW cm^{-2}$). The photovoltaic performances, including the open circuit voltage (V_{oc}) , photocurrents (J_{sc}) , fill factor (FF), and PCE, are summarized in Table 1. Although loading with less amount of dye, SnO₂ nano hollow DSSC exhibits a higher efficiency than the DSSC based on $SnO₂$ nanocrystal. The nano hollow $SnO₂$ can enhance the light harvesting efficiency due to a higher light scattering ability than the $SnO₂$ nanocrystal (Fig. S2†).^{46,47} Additionally, we can see that both V_{oc} and J_{sc} are improved after Ga-doping, and the Ga-doped SnO₂ electrodes showed a better performance than those of undoped $SnO₂$ nano hollow spheres. The observed shifts of the flat band potential for the samples doped with 1 and 3 mol% of Ga are in agreement with the V_{oc} variation. For the samples doped with 5 mol% of Ga, the decrease of the photovoltaic characteristics of the DSSCs is attributed to the decrease of the electrical conductance of the $SnO₂$ films (Fig. S3†). And the overall performance of the films

Fig. 3 X-ray photoelectron spectra of the $Sn_{0.97}Ga_{0.03}O_2$ sample: (a) Sn3d, (b) Ga2p.

Fig. 4 $(J-V)$ curves measured for SnO₂ and Ga-doped SnO₂ photoanodes sensitized with N3 dye.

decrease due to the introduction of too many impurities. On the other hand, $J_{\rm sc}$ can be influenced by the light-harvesting efficiency, electrons injection rate, and charge recombination process. The light harvesting efficiency is a strong function of the dye loading. The $J_{\rm sc}$ factor for the given dye and cell design can be determined by: $J_{\rm sc} = \int_{\lambda} LHE(\lambda)\Phi_{\rm inject.}\eta_{\rm collect.}d\lambda$. As shown in Table S2,† the dye loading amount increases with the increasing doping content (mainly due the increasing of specific surface area, Table 2), which partially contributed to the $J_{\rm sc}$ enhancement. According to the Katoh's report,⁴⁸ the injection efficiency from excited N3 dyes to the conduction band of $SnO₂$ are very high, suggesting that the injection process is not a limiting process for $J_{\rm sc}$. Therefore, to improve the charge collection efficiency will be the additional approach to increasing $J_{\rm sc}$ (which will be discussed later). To further improve the performance of the DSSCs, we treated the electrode films with TiCl₄. When TiCl₄ modifies the photoanode films, the performance of DSSCs is optimized and the efficiency of the $Sn_{0.97}Ga_{0.03}O_2$ photoanode reaches up to 7.11%, which is larger than that for our previous Al-doped $SnO₂$ DSSCs (6.91%) and one of the highest so far to compare with the other reported high values for $SnO₂$ based DSSCs (Table S1†). The photovoltaic parameters are indicated in Table S2† to compare with the DSSCs with and without TiCl_4 treatment. **Puper**

Pup de Conservation de Conservation

The charge transfer and recombination behavior in the $SnO₂$ and Ga-doped $SnO₂$ films was studied by analyzing the EIS spectra at open circuit voltage and the Nyquist plots as shown in

Fig. 5. The EIS spectra are characterized by the presence of two semicircles in a Nyquist plot. The high frequency semicircle is resulted from the charge transfer resistance (R_{ct}) at the interfaces of the electrolyte/counter electrode, while the low frequency one is related to the chemical capacitance of $SnO₂$ and the charge recombination resistance (R_{rec}) between SnO₂ and the electrolyte. We found that the R_{rec} increased with the raising Ga-doping content in $SnO₂$ films, which resulted in the highest $J_{\rm sc}$ and $V_{\rm oc}$ achieved for the Ga-doped cells.

To further analyze the dynamics of electron transport and charge recombination of the DSSCs, intensity-modulated photocurrent spectroscopy (IMPS) and intensity-modulated photovoltage spectroscopy (IMVS) are performed as shown in Fig. 6. The IMVS shows that the lifetime or recombination time (τ_n) of the Ga-doped SnO₂ is larger than that of the undoped $SnO₂$, which is indicative of the higher photovoltage of the Gadoped $SnO₂$ than that of undoped $SnO₂$, in agreement with the results of EIS measurement. This result is similar to the Aldoping cases, which also show an enlarged electron lifetime, but the degree is a little smaller for Ga-doping, indicating a more effective charge recombination suppression for Aldoping. However, the transport time (τ_d) of the Ga-doped SnO2 based cells increases with the increasing Ga-doping content, indicating a more slowly electron transport than that of the undoped SnO₂ based cell. The increased τ_d after Gadoping is similar to that for the Al-doping cases, but the increasing degree is slighter for Ga-doping. The τ_d increases

Table 1 Evolution of cell characteristics for SnO₂ and Ga-doped SnO₂ films, with and without TiCl₄ post-treatment. All data presented are average data obtained from 5 cells

	$J_{\rm sc}\,(\rm{mA}\,\rm{cm}^{-2})$	$V_{\rm oc}$ (mV)	η (%)	FF	Dye loading $(\times 10^{-7} \text{ mol cm}^{-2})$
Nano-SnO 2 ^a	7.92	467	2.03	0.55	0.77
SnO ₂	7.23	496	2.13	0.60	0.62
$Sn_{0.99}Ga_{0.01}O_2$	8.73	517	2.68	0.60	0.70
$Sn_{0.97}Ga_{0.03}O_2$	11.62	565	3.84	0.59	0.74
$Sn_{0.95}Ga_{0.05}O_2$	9.50	547	2.96	0.57	0.76
$SnO_2/TiCl_4$	11.42	601	4.67	0.68	0.93
$Sn_{0.99}Ga_{0.01}O_2/TiCl_4$	13.59	640	5.91	0.68	1.06
$Sn_{0.97}Ga_{0.03}O_2/TiCl_4$	15.61	691	7.11	0.66	1.11
$Sn_{0.95}Ga_{0.05}O_2/TiCl_4$	12.90	665	5.49	0.64	1.13

 a Ref. 31.

Table 2 BET specific surface area (SSA) of the as synthesized samples determined from N_2 sorption analysis

Sample	BET SSA $(m^2 g^{-1})$
SnO ₂	21.48
$Sn_{0.99}Ga_{0.01}O_2$	25.15
$Sn_{0.97}Ga_{0.03}O_2$	28.55
$Sn_{0.95}Ga_{0.05}O_{2}$	30.14

Fig. 5 Nyquist plots of the cells with electrodes at open circuit. Inset shows the corresponding equivalent circuit.

from 17.9 ms to 40 ms when the Al content increases from 0 to 3 mol%, but the τ_d only increases from 15.2 ms to 21.1 ms when the Ga content increases from 0 to 5 mol%. The charge collection efficiency (η_{cc}) was introduced to quantitative analysis of the effect of transport time and electron lifetime. The η_{cc} of the DSSCs can be calculated according to the relation: $\eta_{cc} = 1 - (\tau_d / \tau_d)$ τ_n). The obtained η_{cc} value for SnO₂, Sn_{0.99}Ga_{0.01}O₂, $Sn_{0.97}Ga_{0.03}O_2$, and $Sn_{0.95}Ga_{0.05}O_2$ were 95.9%, 97.2%, 98.1%, and 97.8%, respectively. Thus, the higher $\eta_{\rm cc}$ value for Ga-doped $SnO₂$ cells can result in a higher short circuit current (J_{sc}) density than that of the undoped $SnO₂$ for DSSCs.

Density functional theory (DFT) calculations were performed for our materials to explore the effect of Sn atoms partially substituted by the Ga atoms. Fig. 7(a) shows the doping model.

For each x value, we have considered at least four substitution structures and found out that the uniform doping is the most energy stable doping style. The calculated lattice parameters of bulk $SnO₂$ are listed in Table S2.† The lattice parameters for the pure SnO₂ agree well with experimental results, and they reduce a little after Ga doping due to the smaller ionic radius of Ga. Fig. 7(b)–(d) show the band structures and density of states (DOS) for pure $SnO₂$ and Ga doped $SnO₂$. The calculated band gap of $SnO₂$ is 3.43 eV, close to the experimental value of 3.597 eV. From Fig. 7, our calculation clearly revealed a gradual upward (to high energies) shift for the valence and conduction band with Sn substituted by Ga. The Fermi level shifts positively (downward) to the valence band shows there is an p-type doping effect when Sn substituted by Ga for $SnO₂$, which is attributed to that the heterovalent substitution of Sn atoms $(4+)$ by Ga atoms (3+) introduces charge holes at the Ga sites. The band gap is also reduced a little when the Sn atoms are substituted by the Ga atoms (Fig. $7(b)$). The upward shift for the conduction band minimum (CBM) is consistent with our experimental observation that the conduction band shifts negatively (upward) after Ga doping and increased V_{oc} was obtained. At the same time, the p-type doping effect and the reduced band gap would increase the electrical conductance, which is consistent with the increased $J_{\rm sc}$ when the Ga doping content is increased from 0 to 3 mol%. According to the equation $\sigma = n e \mu$ (*n* is the carrier concentration, μ is the carrier mobility), the electrical conductance of $SnO₂$ would be increased after Ga doping under low content, due to the increased hole concentration. However, the increasing Ga contents could also introduce more impurity scattering centers to impede the electron transport (μ) , and this effect would even dominate to reduce the whole electrical conductance when the Ga doping content exceeds some content. This is consistent with the increased electron transport time (τ_d) observed in the IMPS measurements and also accounts for the reduced $J_{\rm sc}$ when the Ga doping content is increased from 3 mol% to 5 mol%. It's hard to give a clear and direct relationship between the p-type doping effect and the suppressed charge recombination in Ga-doped SnO₂ DSSCs experimentally and theoretically. The most probable reason accounting for this is that the heterovalent Ga doping introduces charge holes (p-type doping) in the bulk and surface of SnO2. These charge holes can attract electrons and act like **PUBLIC MARK ARE**

THE SACTOR THE SACTOR CONSULTED AND THE SACTOR CONSU

Fig. 6 Complex plane plots and the corresponding time constant of the pure-SnO₂ and Ga-doped SnO₂ cells obtained from (a) IMPS and (b) IMVS.

Fig. 7 (a) Configurations of Sn_{0.9375}Ga_{0.0625}O₂. Grey ball: Sn; green ball: Ga; red ball: O. (b) Valance band maximum (VBM) shift (red line) and variation of the band gap (blue line) as a function of the level of Sn substitution by Ga. The Fermi level is set to zero. (c and d) Band structures for the pure SnO₂ and 6.25 mol% Ga doped SnO₂. The Fermi level is set to zero. (e and f) Total and projected density of states for the pure SnO₂ and 6.25 mol% Ga doped SnO₂. The Fermi level is set to zero. The vertical dashed line denotes the Fermi level.

charge trapping sites, to suppress the recombination between the electrons transferred from adsorbed dyes and the holes of the dyes and the redox mediator $(I^-/{I_3}^-)$ in the electrolyte. In our previous work, the Al doping shows a more effective charge recombination suppression.³¹ This is attributed to that a surface Al_2O_3 layer was formed on Al-doped SnO₂, which acts as a thin coated insulating layer and increases the interface resistance greatly to further inhibit the electron–hole recombination.

Conclusions

In summary, by introducing the rough hollow microspheres structure and Ga-doping technique, the highest power conversion efficiency (η) up to 7.11% is obtained, which is larger than that for our previous Al-doped $SnO₂$ DSSCs (6.91%) and one of the highest overall photoconversion efficiency for $SnO₂$ based DSSCs. The Ga-doping results in a negative shift of the CB and the reduction of charge recombination so as to significantly enhance $J_{\rm sc}$ and $V_{\rm oc}$. The highest power conversion efficiency (η) under AM1.5 simulated solar illumination (100 mW cm^{-2}) is obtained at the Ga doping amount of 3 mol%. These findings provide a new route to enhance the performance of DSSCs by improving the two key factors, such as to tune the energy levels of $SnO₂$ and to retard charge recombination.

Acknowledgements

This research was supported by Shenzhen Science and Technology Research Grant (No. ZDSY20130331145131323, JCYJ20120614150201123, SGLH20120928095706623 and RSC Advances **RSC Advances** Paper **RSC Advances** Paper **Paper Paper Paper Paper** Paper Pap

JCYJ20120614150338154), National Natural Science Foundation of China (Grant No. 51303186), and National Research Fund for Fundamental Key Project (2012CB932903). Additionally, we acknowledge the support of ShenZhen National Super Computing Center. PSC Advances

Property and Marine Control National Science Protect. 23 Y. F. Wong, K. M. Lic, L. Ling, Y. F. Hoo C. V. Straits Protect.

Property Control National King and Marinen Receivers.

The Control National Hope Proj

References

- 1 J. Preat, D. Jacquemin and E. A. Perpete, Energy Environ. Sci., 2010, 3, 891–904.
- 2 A. Hagfeldt, G. Boschloo, L. Sun, L. Kloo and H. Pettersson, Chem. Rev., 2010, 110, 6595–6663.
- 3 A. Yella, H. W. Lee, H. N. Tsao, C. Yi, A. K. Chandiran, M. K. Nazeeruddin, E. W. G. Diau, C. Y. Yeh, S. M. Zakeeruddin and M. Grätzel, Science, 2011, 334, 629– 634.
- 4 W. Guo, Y. Shen, L. Wu, Y. Gao and T. Ma, J. Phys. Chem. C, 2011, 115, 21494–21499.
- 5 K. Park, Q. Zhang, B. B. Garcia, X. Zhou, Y. H. Jeong and G. Cao, Adv. Mater., 2010, 22, 2329–2332.
- 6 J. Xiao, Q. Huang, J. Xu, C. Li, G. Chen, Y. Luo, D. Li and Q. Meng, J. Phys. Chem. C, 2014, 118, 4007–4015.
- 7 J. Huo, Y. Hu, H. Jiang, W. Huang and C. Li, J. Mater. Chem. A, 2014, 2, 8266–8272.
- 8 F. Lenzmann, J. Krueger, S. Burnside, K. Brooks, M. Gratzel, D. Gal, S. Ruhle and D. Cahen, J. Phys. Chem. B, 2001, 105, 6347–6352.
- 9 Z. D. Li, Y. Zhou, J. Y. Zhang, W. G. Tu, Q. Liu, T. Yu and Z. G. Zou, Cryst. Growth Des., 2012, 12, 1476–1481.
- 10 Y. Furubayashi, T. Hitosugi and Y. Yamamoto, Appl. Phys. Lett., 2005, 86, 252101.
- 11 J. F. Qian, P. Liu, Y. Xiao, Y. Jiang, Y. L. Cao, X. P. Ai and H. X. Yang, Adv. Mater., 2009, 21, 3663.
- 12 M. K. I. Senevirathna, P. Pitigala, E. V. A. Premalal, K. Tennakone, G. R. A. Kumara and A. Konno, Sol. Energy Mater. Sol. Cells, 2007, 91, 544–547.
- 13 H. C. Pang, H. B. Yang, C. X. Guo and C. M. Li, ACS Appl. Mater. Interfaces, 2012, 4, 6261–6265.
- 14 M. H. Kim and Y. U. Kwon, J. Phys. Chem. C, 2011, 115, 23120–23125.
- 15 E. Ramasamy and J. Lee, J. Phys. Chem. C, 2010, 114, 22032– 22037.
- 16 S. Gubbala, V. Chakrapani, V. Kumar and M. K. Sunkara, Adv. Funct. Mater., 2008, 18, 2411–2418.
- 17 X. C. Dou, D. Sabba, N. Mathews, L. H. Wong, Y. M. Lam and S. Mhaisalkar, Chem. Mater., 2011, 23, 3938–3945.
- 18 K. Perera, S. G. Anuradha, G. R. A. Kumara, M. L. Paranawitharana, R. M. G. Rajapakse and H. M. N. Bandara, Electrochim. Acta, 2011, 56, 4135–4138.
- 19 P. Docampo, P. Tiwana, N. Sakai, H. Miura, L. Herz, T. Murakami and H. J. Snaith, J. Phys. Chem. C, 2012, 116, 22840–22846.
- 20 C. T. Gao, X. D. Li, B. G. Lu, L. L. Chen, Y. Q. Wang, F. Teng, J. T. Wang, Z. X. Zhang, X. J. Pan and E. Q. Xie, Nanoscale, 2012, 4, 3475–3481.
- 21 H. Wang, B. Li, J. Gao, M. Tang, H. B. Feng, J. H. Li and L. Guo, Crystengcomm, 2012, 14, 5177–5181.
- 22 Y. F. Wang, K. N. Li, C. L. Liang, Y. F. Hou, C. Y. Su and D. B. Kuang, J. Mater. Chem., 2012, 22, 21495–21501.
- 23 P. N. Zhu, M. V. Reddy, Y. Z. Wu, S. J. Peng, S. Y. Yang, A. S. Nair, K. P. Loh, B. V. R. Chowdari and S. Ramakrishna, Chem. Commun., 2012, 48, 10865–10867.
- 24 R. Kasaudhan, H. Elbohy, S. Sigdel, Q. Hui, W. Qufu and Q. Qiquan, IEEE Electron Device Lett., 2014, 35, 578–580.
- 25 X. Zou, X. Liu, C. Wang, Y. Jiang, Y. Wang, X. Xiao, J. C. Ho, J. Li, C. Jiang, Q. Xiong and L. Liao, ACS Nano, 2012, 7, 804–810.
- 26 Q. Zhao, P. Wu, B. L. Li and E. Y. Jiang, Phys. Rev. B: Condens. Matter, 2012, 407, 171–174.
- 27 S. H. Park, J. B. Park and P. K. Song, Curr. Appl. Phys., 2010, 10, S488–S490.
- 28 X. Lü, X. Mou, J. Wu, D. Zhang, L. Zhang, F. Huang, F. Xu and S. Huang, Adv. Funct. Mater., 2010, 20, 509–515.
- 29 K. P. Wang and H. Teng, Phys. Chem. Chem. Phys., 2009, 11, 9489–9496.
- 30 J. J. Teh, S. L. Ting, K. C. Leong, J. Li and P. Chen, ACS Appl. Mater. Interfaces, 2013, 5, 11377–11382.
- 31 Y. Duan, J. Zheng, N. Fu, Y. Fang, T. Liu, Q. Zhang, X. Zhou, Y. Lin and F. Pan, J. Mater. Chem. A, 2015, 3, 3066–3073.
- 32 P. Bonhôte, A. P. Dias, N. Papageorgiou, K. Kalyanasundaram and M. Grätzel, Inorg. Chem., 1996, 35, 1168–1178.
- 33 P. E. Blochl, Phys. Rev. B: Condens. Matter Mater. Phys., 1994, 50, 17953–17979.
- 34 G. Kresse and D. Joubert, Phys. Rev. B: Condens. Matter Mater. Phys., 1999, 59, 1758–1775.
- 35 J. Heyd, G. E. Scuseria and M. Ernzerhof, J. Chem. Phys., 2003, 118, 8207.
- 36 J. Heyd, G. E. Scuseria and M. Ernzerhof, J. Chem. Phys., 2006, 124, 219906.
- 37 G. Kresse and J. Furthmuller, Phys. Rev. B: Condens. Matter Mater. Phys., 1996, 54, 11169–11186.
- 38 G. Kresse and J. Furthmuller, Comput. Mater. Sci., 1996, 6, 15–50.
- 39 J. Paier, M. Marsman, K. Hummer, G. Kresse, I. C. Gerber and J. G. Angyán, *J. Chem. Phys.*, 2006, 124, 154709.
- 40 J. P. Perdew, K. Burke and M. Ernzerhof, Phys. Rev. Lett., 1996, 77, 3865–3868.
- 41 J. B. Varley, A. Janotti and C. G. Van de Walle, Phys. Rev. B: Condens. Matter Mater. Phys., 2010, 81, 245216.
- 42 D. O. Demchenko, B. Earles, H. Y. Liu, V. Avrutin, N. Izyumskaya, Ü. Özgür and H. Morkoç, *Phys. Rev. B:* Condens. Matter Mater. Phys., 2011, 84, 075201.
- 43 T. L. Barr, M. A. Lishka, L. M. Chen and M. Mohsenian, J. Am. Chem. Soc., 1988, 110, 7962–7975.
- 44 J. Li and H. C. Zeng, J. Am. Chem. Soc., 2007, 129, 15839– 15847.
- 45 G. Schon, J. Electron. Spectrosc. Relat. Phenom., 1973, 2, 75– 86.
- 46 J. Xing, W. Q. Fang, Z. Li and H. G. Yang, Ind. Eng. Chem. Res., 2012, 51, 4247–4253.
- 47 S. Yang, Y. Hou, J. Xing, B. Zhang, F. Tian, X. H. Yang and H. G. Yang, Chem.–Eur. J., 2013, 19, 9366–9370.
- 48 R. Katoh and A. Furube, J. Photochem. Photobiol., C, 2014, 20, 1–16.